## **CARAC 2019**

## Thursday, 28 November 2019

## Best poster contribution award - ILL4/rdc-1 - Amphi Chadwick (16:30 - 18:30)

time	[id] title	presenter
16:30	[8] Strain mapping of transistor structures in a 22nm Fully Depleted Silicon-On-Insulator technology	Mr KLEIMAIER, Dominik
	[13] Physics-based analytical modeling of AlGaN/GaN HEMT using gate field-plate technology for high-frequency applications	KADDECHE, MOURAD
16:30	[12] InnovaXN : a new PhD programme at ILL and ESRF	BOUDOU, Caroline
	[7] Combined x-ray nano-tomography and Small Angle Neutron Scattering characterisation applied to reliability and process development	Mr VARELA DELLA GIUSTINA, rafael
16:30	[9] Better in Vacuum - how vacuum can improve investigation of 2D materials using conductive Atomic Force Microscopy (AFM)	BOURRELLIER, Romain LEFEVRE, Matthew
16:30	[10] SINE2020: how a European project has provided access to neutron measurement techniques for various industrial sectors	BOUDOU, Caroline
16:30	[11] Through thickness non-destructive residual stress-mapping on 6 mm thick Al-plates with neutron diffraction	BOUDOU, Caroline